

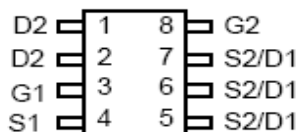
**AO4928**
**Asymmetric Dual N-Channel Enhancement Mode Field Effect Transistor**  
**SRFET™**
**General Description**

The AO4928 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. The two MOSFETs make a compact and efficient switch and synchronous rectifier combination for use in DC-DC converters. A monolithically integrated Schottky diode in parallel with the synchronous MOSFET to boost efficiency further. *Standard Product AO4928 is Pb-free (meets ROHS & Sony 259 specifications). AO4928L is a Green Product ordering option. AO4928L and AO4928 are electrically identical.*

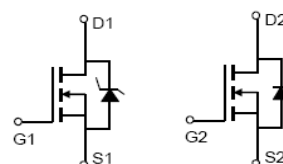
**Features**
**FET1**
 $V_{DS} (V) = 30V$ 
 $I_D = 9A$ 
 $R_{DS(ON)} < 16m\Omega$ 
 $R_{DS(ON)} < 19.5m\Omega$ 
**FET2**
 $V_{DS}(V) = 30V$ 
 $I_D = 7.3A$  ( $V_{GS} = 10V$ )

 $< 24m\Omega$  ( $V_{GS} = 10V$ )

 $< 29m\Omega$  ( $V_{GS} = 4.5V$ )

**UIS TESTED!**
**Rg,Ciss,Coss,Crss Tested**
**SOIC-8**

**SRFET™**

Soft Recovery MOSFET:  
Integrated Schottky Diode


**Absolute Maximum Ratings  $T_A = 25^\circ C$  unless otherwise noted**

| Parameter                                            | Symbol             | Max FET1   | Max FET2   | Units      |
|------------------------------------------------------|--------------------|------------|------------|------------|
| Drain-Source Voltage                                 | $V_{DS}$           | 30         | 30         | V          |
| Gate-Source Voltage                                  | $V_{GS}$           | $\pm 12$   | $\pm 12$   | V          |
| Continuous Drain Current <sup>A</sup>                | $T_A = 25^\circ C$ | 9.0        | 7.3        | A          |
|                                                      | $T_A = 70^\circ C$ | 7.2        | 5.9        |            |
| Pulsed Drain Current <sup>B</sup>                    | $I_{DM}$           | 40         | 40         |            |
| Avalanche Current <sup>C</sup>                       | $I_{AR}$           | 16         | 12         | A          |
| Repetitive avalanche energy $L = 0.3mH$ <sup>C</sup> | $E_{AR}$           | 38         | 22         | mJ         |
| Power Dissipation                                    | $T_A = 25^\circ C$ | 2.0        | 2.0        | W          |
|                                                      | $T_A = 70^\circ C$ | 1.3        | 1.3        |            |
| Junction and Storage Temperature Range               | $T_J, T_{STG}$     | -55 to 150 | -55 to 150 | $^\circ C$ |

**Thermal Characteristics FET1**

| Parameter                                             | Symbol          | Typ | Max  | Units        |
|-------------------------------------------------------|-----------------|-----|------|--------------|
| Maximum Junction-to-Ambient <sup>A</sup> $t \leq 10s$ | $R_{\theta JA}$ | 48  | 62.5 | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup> Steady-State |                 | 74  | 90   | $^\circ C/W$ |
| Maximum Junction-to-Lead <sup>C</sup> Steady-State    | $R_{\theta JL}$ | 32  | 40   | $^\circ C/W$ |

**Thermal Characteristics FET2**

| Parameter                                             | Symbol          | Typ | Max  | Units        |
|-------------------------------------------------------|-----------------|-----|------|--------------|
| Maximum Junction-to-Ambient <sup>A</sup> $t \leq 10s$ | $R_{\theta JA}$ | 48  | 62.5 | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup> Steady-State |                 | 74  | 90   | $^\circ C/W$ |
| Maximum Junction-to-Lead <sup>C</sup> Steady-State    | $R_{\theta JL}$ | 32  | 40   | $^\circ C/W$ |

FET1 Electrical Characteristics ( $T_J=25^{\circ}\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                                        | Conditions                                                                         | Min | Typ          | Max        | Units         |
|-----------------------------|--------------------------------------------------|------------------------------------------------------------------------------------|-----|--------------|------------|---------------|
| <b>STATIC PARAMETERS</b>    |                                                  |                                                                                    |     |              |            |               |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage                   | $I_D=250\mu\text{A}$ , $V_{GS}=0\text{V}$                                          | 30  |              |            | V             |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current                  | $V_{DS}=24\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=125^{\circ}\text{C}$              |     | 0.01<br>5    | 0.1<br>10  | mA            |
| $I_{GSS}$                   | Gate-Body leakage current                        | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 12\text{V}$                                       |     |              | 0.1        | $\mu\text{A}$ |
| $V_{GS(th)}$                | Gate Threshold Voltage                           | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$                                             | 1.5 | 1.85         | 2.4        | V             |
| $I_{D(ON)}$                 | On state drain current                           | $V_{GS}=4.5\text{V}$ , $V_{DS}=5\text{V}$                                          | 40  |              |            | A             |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance                | $V_{GS}=10\text{V}$ , $I_D=9\text{A}$<br>$T_J=125^{\circ}\text{C}$                 |     | 13.2<br>20.5 | 16<br>25.6 | m $\Omega$    |
|                             |                                                  | $V_{GS}=4.5\text{V}$ , $I_D=7\text{A}$                                             |     | 15.7         | 19.5       | m $\Omega$    |
| $g_{FS}$                    | Forward Transconductance                         | $V_{DS}=5\text{V}$ , $I_D=9\text{A}$                                               |     | 64           |            | S             |
| $V_{SD}$                    | Diode Forward Voltage                            | $I_S=1\text{A}$ , $V_{GS}=0\text{V}$                                               |     | 0.4          | 0.6        | V             |
| $I_S$                       | Maximum Body-Diode + Schottky Continuous Current |                                                                                    |     |              | 4.5        | A             |
| <b>DYNAMIC PARAMETERS</b>   |                                                  |                                                                                    |     |              |            |               |
| $C_{iss}$                   | Input Capacitance                                | $V_{GS}=0\text{V}$ , $V_{DS}=15\text{V}$ , $f=1\text{MHz}$                         |     | 1450         | 1885       | pF            |
| $C_{oss}$                   | Output Capacitance                               |                                                                                    |     | 224          |            | pF            |
| $C_{rss}$                   | Reverse Transfer Capacitance                     |                                                                                    |     | 92           |            | pF            |
| $R_g$                       | Gate resistance                                  | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                          |     | 1.6          | 3          | $\Omega$      |
| <b>SWITCHING PARAMETERS</b> |                                                  |                                                                                    |     |              |            |               |
| $Q_g(10\text{V})$           | Total Gate Charge                                | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $I_D=9\text{A}$                        |     | 24.0         | 31         |               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                                |                                                                                    |     | 12.0         |            | nC            |
| $Q_{gs}$                    | Gate Source Charge                               |                                                                                    |     | 3.9          |            | nC            |
| $Q_{gd}$                    | Gate Drain Charge                                |                                                                                    |     | 4.2          |            | nC            |
| $t_{D(on)}$                 | Turn-On DelayTime                                | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $R_L=1.7\Omega$ ,<br>$R_{GEN}=3\Omega$ |     | 5.5          |            | ns            |
| $t_r$                       | Turn-On Rise Time                                |                                                                                    |     | 4.7          |            | ns            |
| $t_{D(off)}$                | Turn-Off DelayTime                               |                                                                                    |     | 24.0         |            | ns            |
| $t_f$                       | Turn-Off Fall Time                               |                                                                                    |     | 4.0          |            | ns            |
| $t_{rr}$                    | Body Diode Reverse Recovery Time                 | $I_F=9\text{A}$ , $dI/dt=300\text{A}/\mu\text{s}$                                  |     | 10           | 13         | ns            |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge               | $I_F=9\text{A}$ , $dI/dt=300\text{A}/\mu\text{s}$                                  |     | 6.8          |            | nC            |

A: The value of  $R_{\theta JA}$  is measured with the device in a still air environment with  $T_A=25^{\circ}\text{C}$ . The power dissipation  $P_{DSM}$  and current rating  $I_{DSM}$  are based on  $T_{J(MAX)}=150^{\circ}\text{C}$ , using  $t \leq 10\text{s}$  junction-to-ambient thermal resistance.

B: Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150^{\circ}\text{C}$ .

C: The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ . The SOA curve provides a single pulse rating.

Rev0:Sept 2006

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## FET1 TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

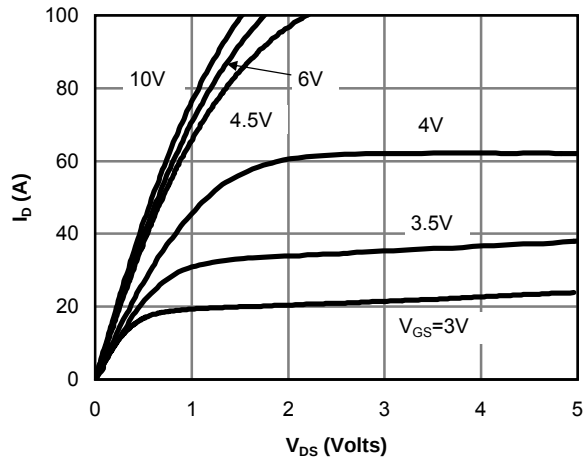


Figure 1: On-Region Characteristics

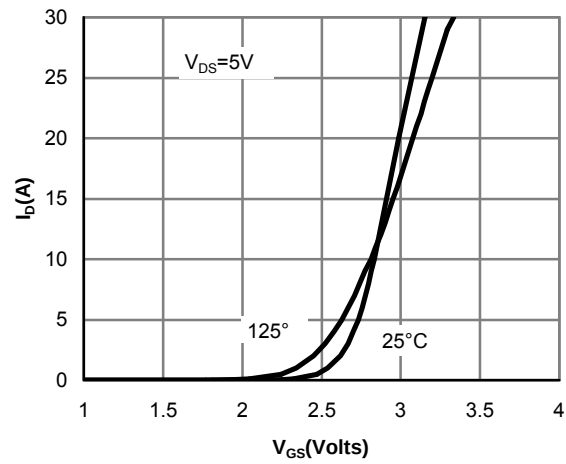


Figure 2: Transfer Characteristics

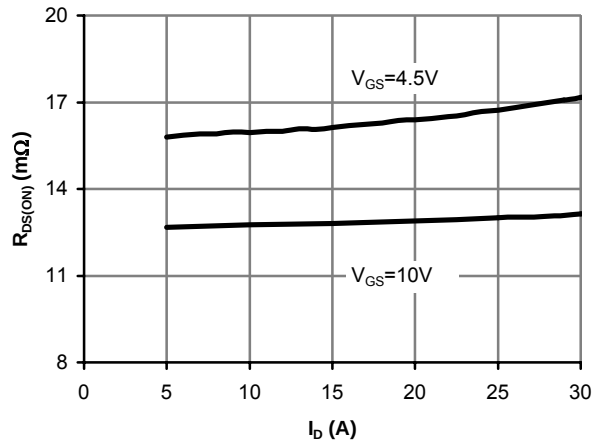


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

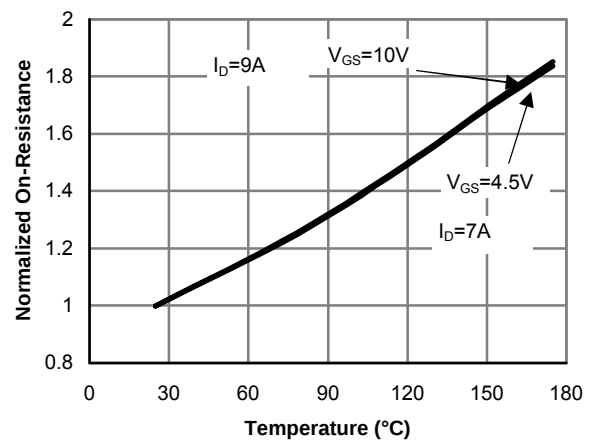


Figure 4: On-Resistance vs. Junction Temperature

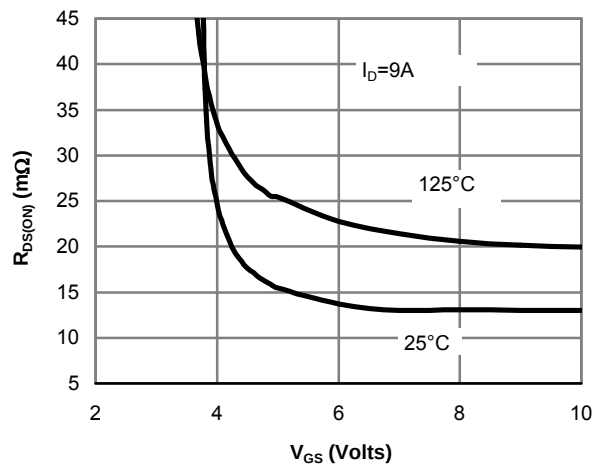


Figure 5: On-Resistance vs. Gate-Source Voltage

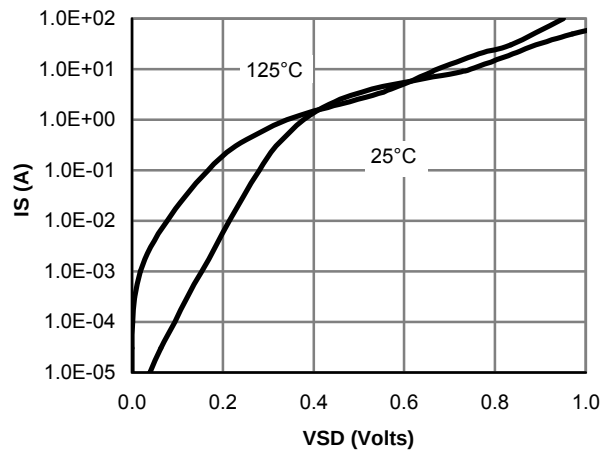


Figure 6: Body-Diode Characteristics

## FET1 TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

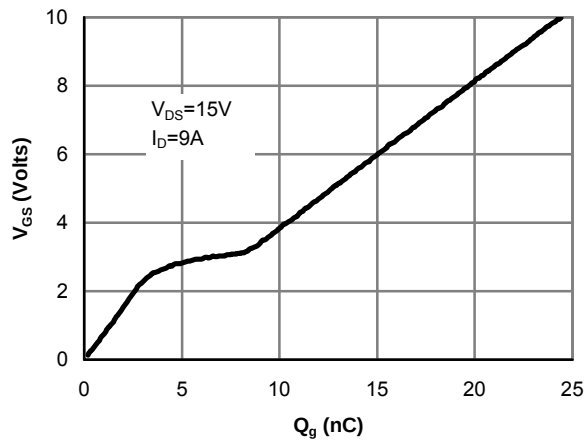


Figure 7: Gate-Charge Characteristics

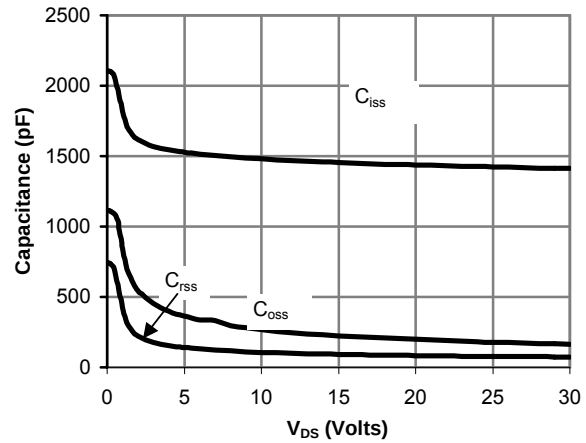


Figure 8: Capacitance Characteristics

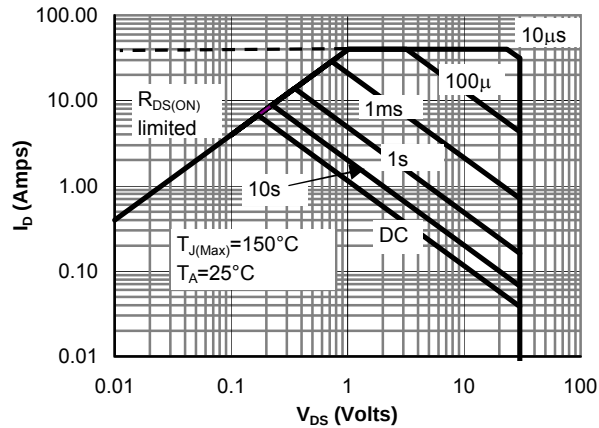


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

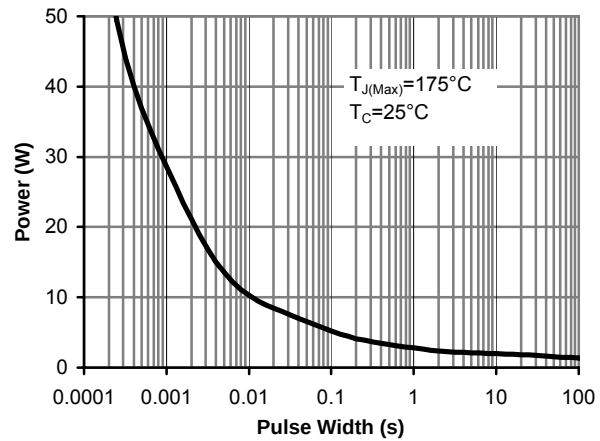


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

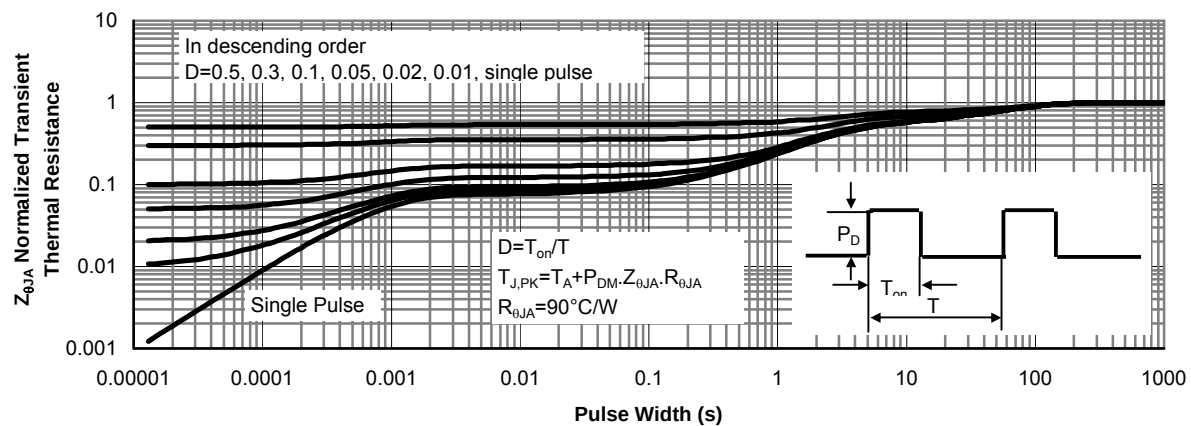


Figure 11: Normalized Maximum Transient Thermal Impedance (Note E)

## FET1 TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

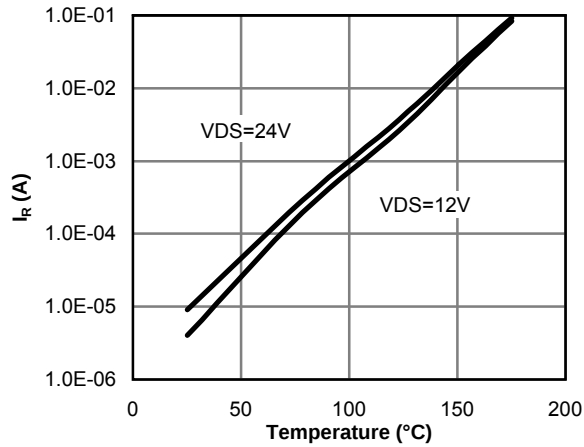


Figure 12: Diode Reverse Leakage Current vs. Junction Temperature

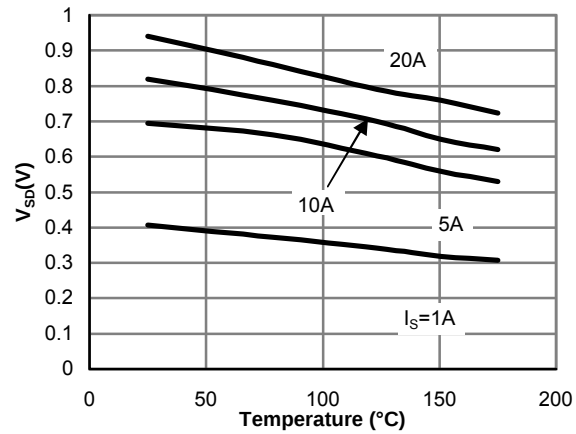


Figure 13: Diode Forward Voltage vs. Junction Temperature

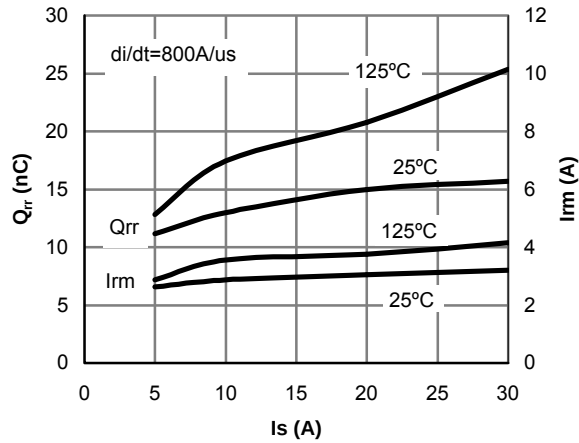


Figure 14: Diode Reverse Recovery Charge and Peak Current vs. Conduction Current

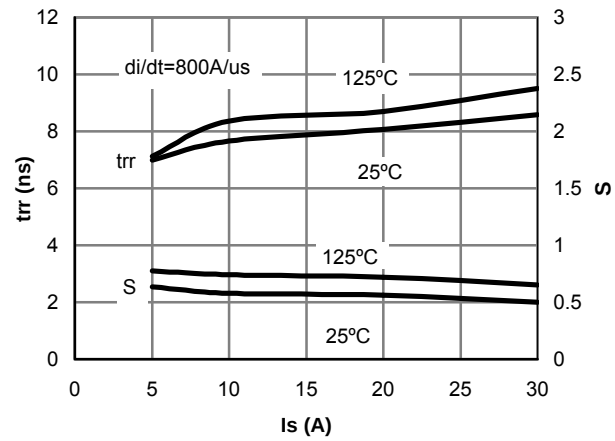


Figure 15: Diode Reverse Recovery Time and Soft Coefficient vs. Conduction Current

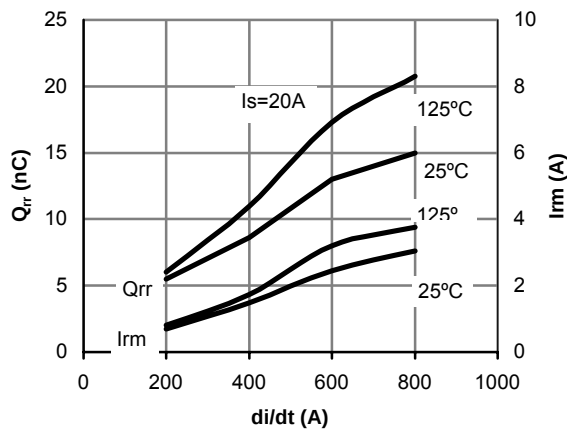


Figure 16: Diode Reverse Recovery Charge and Peak Current vs. di/dt

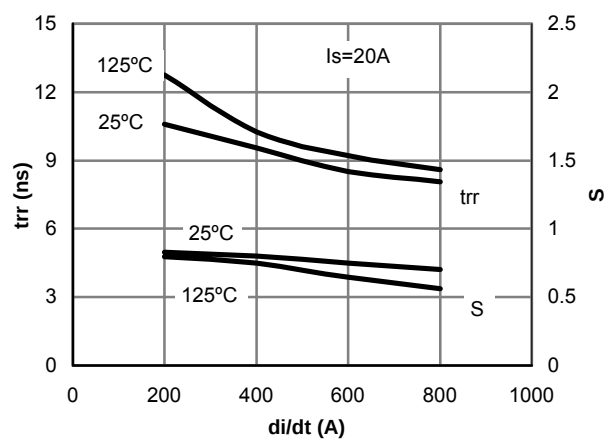


Figure 17: Diode Reverse Recovery Time and Soft Coefficient vs. di/dt

FET2 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                             | Conditions                                                                                | Min | Typ        | Max      | Units |
|-----------------------------|---------------------------------------|-------------------------------------------------------------------------------------------|-----|------------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                           |     |            |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                                | 30  |            |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =24V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                         |     |            | 1<br>5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±12V                                               |     |            | 100      | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                  | 0.7 | 1          | 1.5      | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =4.5V, V <sub>DS</sub> =5V                                                | 40  |            |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =7.3A<br>T <sub>J</sub> =125°C                       |     | 20<br>30.0 | 24<br>36 | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =6A                                                 |     | 23.4       | 29       | mΩ    |
|                             |                                       | V <sub>GS</sub> =2.5V, I <sub>D</sub> =5.5A                                               |     | 35.4       | 48       | mΩ    |
|                             |                                       |                                                                                           |     |            |          |       |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =7.3A                                                 |     | 26         |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                   |     | 0.71       | 1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |                                                                                           |     |            | 4.5      | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                           |     |            |          |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz                                         |     | 900        | 1100     | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |                                                                                           |     | 88         |          | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |                                                                                           |     | 65         |          | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                          |     | 0.95       | 1.5      | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                           |     |            |          |       |
| Q <sub>g</sub>              | Total Gate Charge                     | V <sub>GS</sub> =4.5V, V <sub>DS</sub> =15V, I <sub>D</sub> =7.3A                         |     | 10         |          | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |                                                                                           |     | 1.8        |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |                                                                                           |     | 3.75       |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =2.1Ω,<br>R <sub>GEN</sub> =6Ω |     | 3.2        |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |                                                                                           |     | 3.5        |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |                                                                                           |     | 21.5       |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |                                                                                           |     | 2.7        |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =7.3A, dI/dt=100A/μs                                                       |     | 16.8       |          | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =7.3A, dI/dt=100A/μs                                                       |     | 8          |          | nC    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t<sub>s</sub> 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

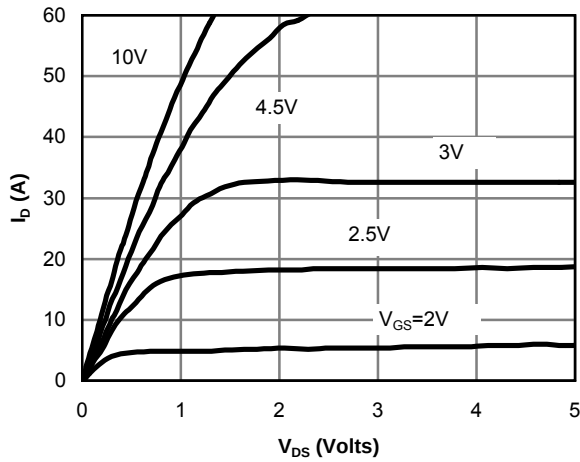


Figure 1: On-Region Characteristics

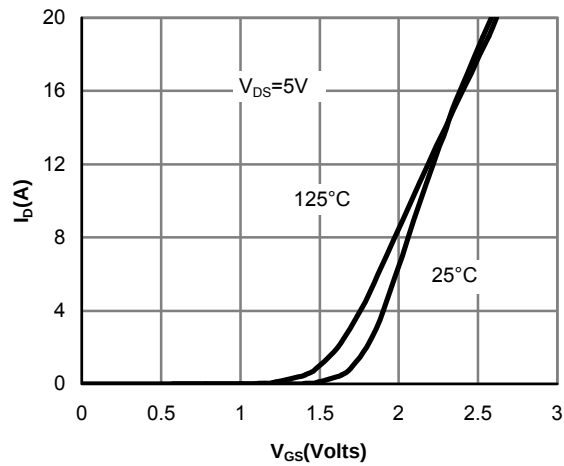


Figure 2: Transfer Characteristics

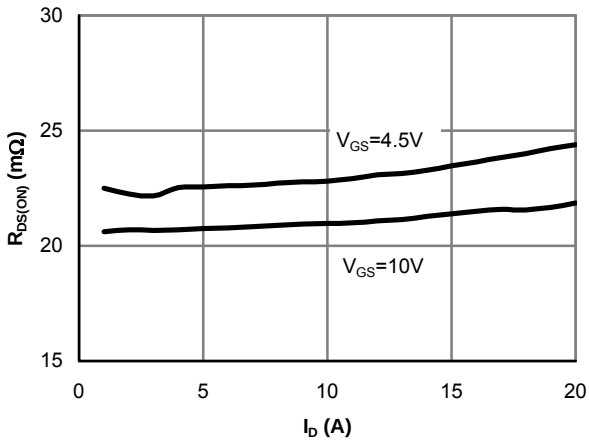


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

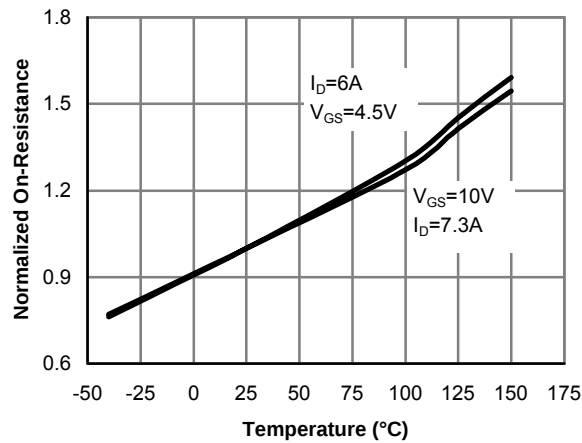


Figure 4: On-Resistance vs. Junction Temperature

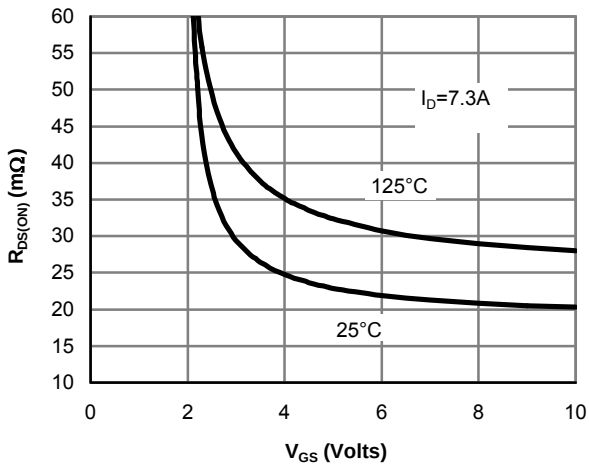


Figure 5: On-Resistance vs. Gate-Source Voltage

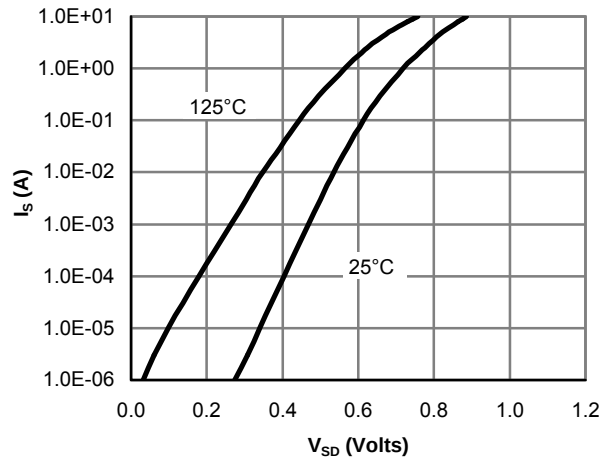


Figure 6: Body-Diode Characteristics

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

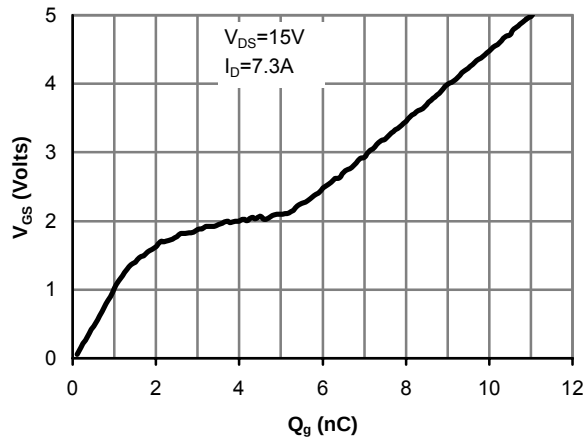


Figure 7: Gate-Charge Characteristics

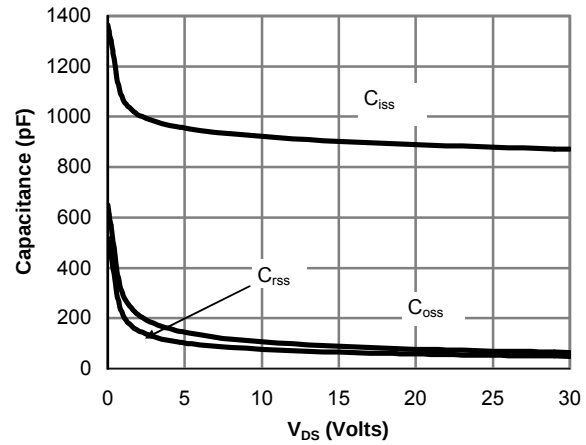


Figure 8: Capacitance Characteristics

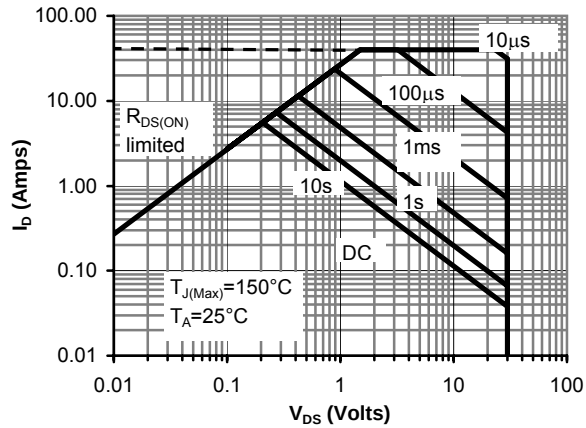


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

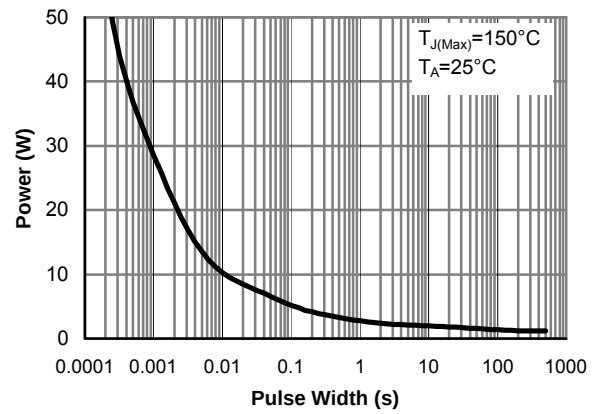


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

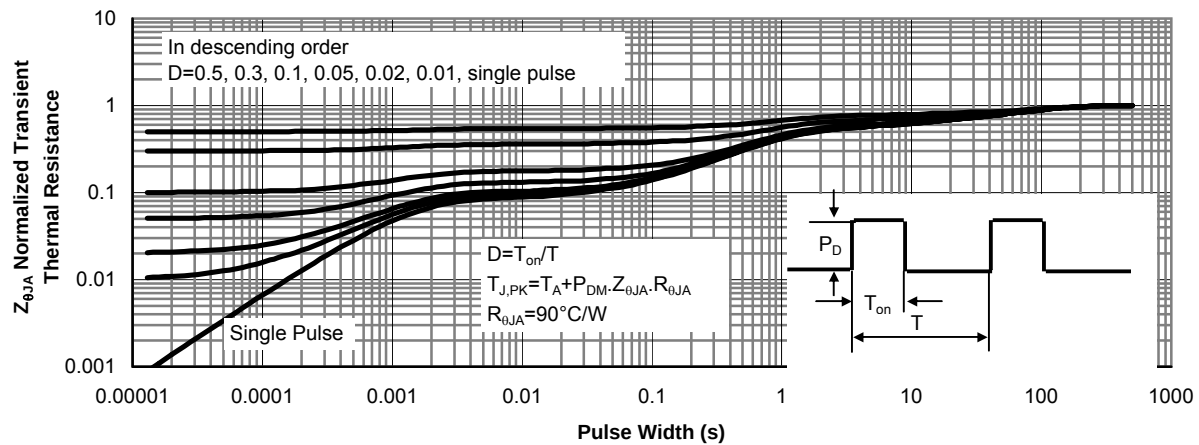


Figure 11: Normalized Maximum Transient Thermal Impedance